Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,283	CHAPMAN, THOMAS R.	
Examiner	Art Unit	
Devin Hanan	3745	

Ŷ-	SEARCHED					
Class	Subclass	Date	Examiner			
415	206					
416	175,183					
	185, 187					
	186R					
264	328.1	4/20/2005	DH			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
-	<del>                                     </del>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
consulted Chris Verdier on class 416 and 415	4/20/2005	DH	
consulted Jill Heitbrink on class 264/328.1	4/13/2005	DH	